



INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use as many sheets as necessary)				Complete if Known	
				Application Number	10/817,355
				Filing Date	April 1, 2004
				First Named Inventor	WOODS
				Art Unit	1765
				Examiner Name	Unassigned
				Attorney Docket Number	LAM2P472
Sheet	1	of	4		

U.S. Patent Documents

Examiner Initials	Cite No. ¹	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, where Relevant Passages or Relevant Figures Appear
		Number-Kind Code ² (if known)			
/JLP/ ↓ ↓ ↓ ↓ ↓ ↓ ↓ ↓ ↓ ↓ ↓ ↓	A	2003/0091754 A1	05/15/03	Chihani et al.	
	B	2003/0092264 A1	05/15/03	Shinji et al.	
	C	2004/0060573 A1	04/01/04	Woods	
	D	2004/0069319 A1	04/15/04	Boyd et al.	
	E	2004/0069329 A1	04/15/04	de Larios et al.	
	F	2004/0136494 A1	07/15/04	Lof et al.	
	G	2004/0178060 A1	09/16/04	Ravkin et al.	
	H	2004/0182422 A1	09/23/04	Boyd et al.	
	I	2005/0132515 A1	12/18/03	Boyd et al.	06/2005
	J	2005/0139318 A1	06/30/05	Woods et al.	
	K	2005/0145265 A1	07/07/05	Ravkin et al.	
	L	2005/0145267 A1	04/01/04	Korolik et al.	07/2005

Foreign Patent Documents

Examiner Initial	Cite No. ¹	Foreign Patent Document No.	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, where Relevant Passages or Relevant Figures Appear	T ⁶
		Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)				
/JLP/	M	EP 0 905 746 A1	3/31/99	Interniversitair Micro-Elektronica Centrum VZW		<input type="checkbox"/>
/JLP/	N	EP 0 905 747 A1	3/31/99	Interniversitair Micro-Elektronica Centrum VZW		<input type="checkbox"/>

Non Patent Literature Documents

Examiner Initial	Cite No.	Include name of author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published
/JLP/	O	OWA et al. "Immersion lithography; its potential performance and issues", Proceedings of the SPIE, SPIE, Bellingham, VA, US, Vol. 5040, No. 1, February 28, 2003, pages 724-733, XP002294500
/JLP/	P	LIM et al., "Atomic Layer deposition of transition metals", Department of Chemistry and Chemical Biology, Harvard University, Nature Publishing Group, Volume 2, November 2003, Pages 749-754

Examiner Signature	/Joseph L. Perrin/	Date Considered	03/28/2007
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Sheet	2	of	4	Attorney Docket Number	LAM2P472

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		Number-Kind Code ² (if known)			
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	B	2005/0217703 A1	10/06/05	O'Donnell	
	C	2006/0064895 A1	03/30/08	Garcia et al.	
	D	3,953,265	04/27/76	Hood	
	E	4,367,123	01/04/83	Beck	
	F	4,444,492	04/24/84	Lee	
	G	5,102,494	04/07/92	Harvey et al.	
	H	5,180,431	01/19/93	Sugimoto et al.	
	I	5,343,234	08/30/94	Kuehnle	
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	K	5,472,502	12/05/95	Batchelder	
	L	5,558,111	09/24/96	Lofaro	

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Examiner Initial	Cite No. ¹	Foreign Patent Document No.	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, where Relevant Passages or Relevant Figures Appear	T ⁶
		Country Code ³ -Number- ⁴ Kind Code ⁵ (if known)				
/JLP/	M	JP11031672 (Patent Abstract in English provided)	02/02/99	Hitachi Ltd.		<input type="checkbox"/>
/JLP/	N	WO 03/014416 A2	02/20/03	Ebara Corporation		<input type="checkbox"/>

Non Patent Literature Documents

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/JLP/	O	ICKnowledge LLC, "Technology Backgrounder: Atomic Layer Deposition", ICKnowledge.com, 2004, Pages 1-7
/JLP/	P	"Chemical vapor deposition", Wikipedia, the free encyclopedia, http://en.wikipedia.org/wiki/Chemical_vapor_deposition , 2005, Page 1-2

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